

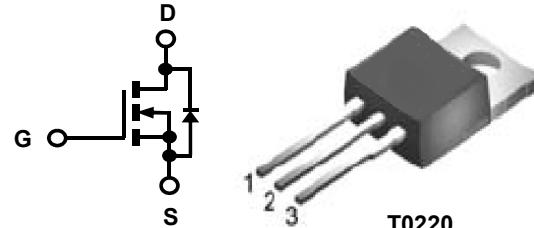
# ICE15N65 N-Channel Enhancement Mode MOSFET


**HALOGEN  
FREE**

Product Summary			
$I_D$	$T_A=25^\circ\text{C}$	15A	Max
$V_{(\text{BR})\text{DSS}}$	$I_D=250\mu\text{A}$	650V	Min
$r_{\text{DS}(\text{on})}$	$V_{GS}=10\text{V}$	0.24Ω	Typ
$Q_g$	$V_{DS}=480\text{V}$	57nC	Typ

## Features

- Low  $r_{\text{DS}(\text{on})}$
- Ultra Low Gate Charge
- High dv/dt capability
- High Unclamped Inductive Switching (UIS) capability
- High peak current capability
- Increased transconductance performance
- Optimized design for high performance power systems



ICEMOS AND ITS SISTER COMPANY 3D SEMI OWN THE FUNDAMENTAL PATENTS FOR SUPERJUNCTION MOSFETS. THE MAJORITY OF THESE PATENTS HAVE 17 to 20 YEARS OF REMAINING LIFE. THIS PORTFOLIO HAS GRANTED PATENTS ISSUED IN USA, CHINA, KOREA, JAPAN, TAIWAN & EUROPE.

Standard Metal Heatsink  
1=Gate, 2=Drain,  
3=Source.

**Maximum ratings** at  $T_j=25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_c=25^\circ\text{C}$ $T_c=100^\circ\text{C}$	15 9	A
Pulsed drain current	$I_{D, \text{pulse}}$	$T_c=25^\circ\text{C}$	45	A
Avalanche energy, single pulse	$E_{AS}$	$I_D=7.5\text{A}$	460	mJ
Avalanche current, repetitive	$I_{AR}$	limited by $T_j\text{max}$	7.5	A
MOSFET dv/dt ruggedness	dv/dt	$V_{DS}=480\text{V}$ , $I_D=15\text{A}$ , $T_j=125^\circ\text{C}$	50	V/ns
Gate source voltage	$V_{GS}$	Static	$\pm 20$	V
		AC ( $f>1\text{Hz}$ )	$\pm 30$	
Power dissipation	$P_{\text{tot}}$	$T_c=25^\circ\text{C}$	156	W
Operating and storage temperature	$T_j$ , $T_{\text{stg}}$		-55 to +150	°C
Mounting torque		M3 & 3.5 screws	60	Ncm

a When mounted on 1inch square 2oz copper clad FR-4

<b>Parameter</b>	<b>Symbol</b>	<b>Conditions</b>	<b>Values</b>			<b>Unit</b>
			<b>Min</b>	<b>Typ</b>	<b>Max</b>	

**Thermal characteristics**

Thermal resistance, junction-case <sup>a</sup>	$R_{thJC}$		-	-	0.8	°C/W
Thermal resistance, junction-ambient <sup>a</sup>	$R_{thJA}$	leaded	-	-	62	
Soldering temperature, wave soldering only allowed at leads	$T_{sold}$	1.6mm (0.063in.) from case for 10 s	-	-	260	°C

**Electrical characteristics** at  $T_j=25^\circ\text{C}$ , unless otherwise specified

**Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0 \text{ V}, I_D=250\mu\text{A}$	650	675	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.1	3.2	3.9	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$	-	0.1	1	μA
		$V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_j=150^\circ\text{C}$	-	50	-	
Gate source leakage current	$I_{GSS}$	$V_{GS}=\pm 20 \text{ V}, V_{DS}=0\text{V}$	-	-	100	nA
Drain-source on-state resistance	$r_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=7.5\text{A}, T_j=25^\circ\text{C}$	-	0.24	0.28	Ω
		$V_{GS}=10\text{V}, I_D=7.5\text{A}, T_j=150^\circ\text{C}$	-	0.65	-	
Gate resistance	$R_G$	$f=1 \text{ MHZ}, \text{open drain}$	-	4.1	-	Ω

**Dynamic characteristics**

Input capacitance	$C_{iss}$	$V_{GS}=0 \text{ V}, V_{DS}=25 \text{ V}, f=1 \text{ MHz}$	-	1734	-	pF
Output capacitance	$C_{oss}$		-	200	-	
Reverse transfer capacitance	$C_{rss}$		-	2.5	-	
Transconductance	$g_{fs}$	$V_{DS}>2*I_D*R_{DS}, I_D=7.5\text{A}$	-	15	-	S
Turn-on delay time	$t_{d(on)}$	$V_{DS}=380\text{V}, V_{GS}=10\text{V}, I_D=15\text{A}, R_G=4\Omega \text{ (External)}$	-	33	-	ns
Rise time	$t_r$		-	42	-	
Turn-off delay time	$t_{d(off)}$		-	105	-	
Fall time	$t_f$		-	27	-	

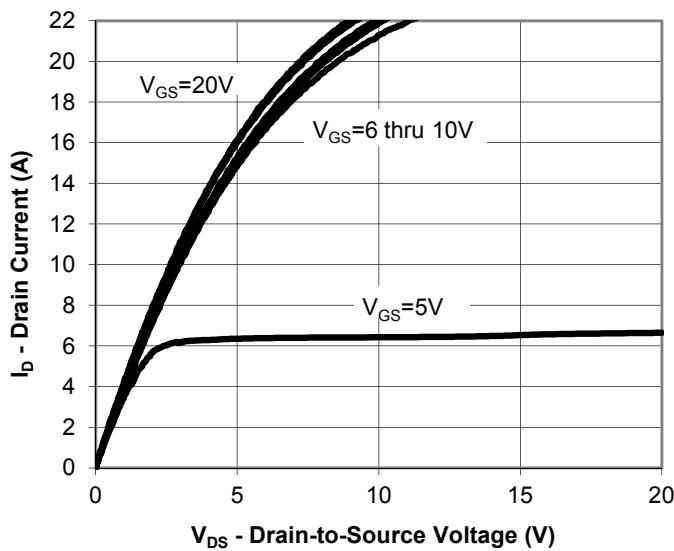
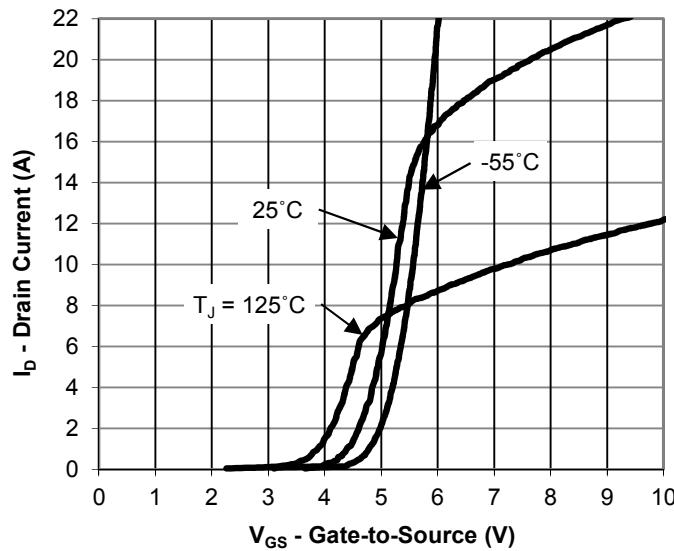
<b>Parameter</b>	<b>Symbol</b>	<b>Conditions</b>	<b>Values</b>			<b>Unit</b>
			<b>Min</b>	<b>Typ</b>	<b>Max</b>	

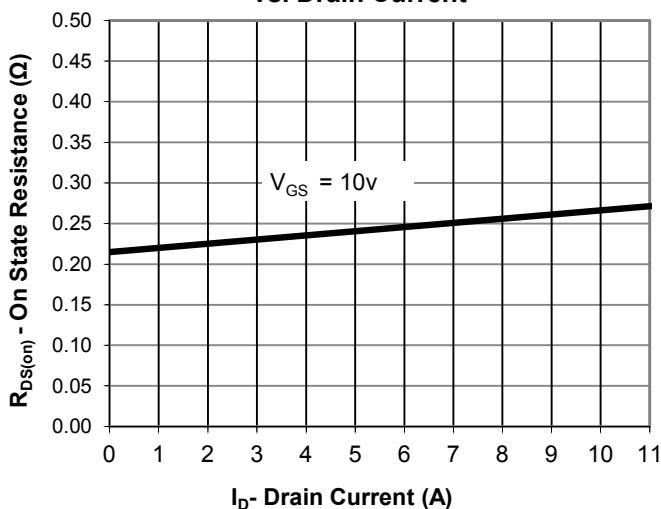
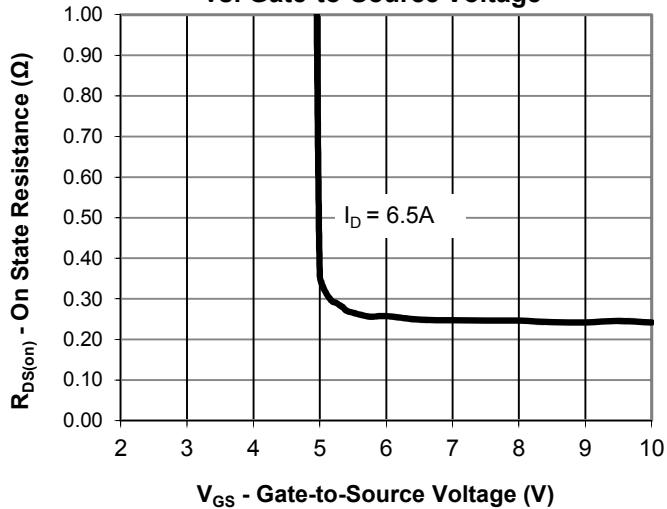
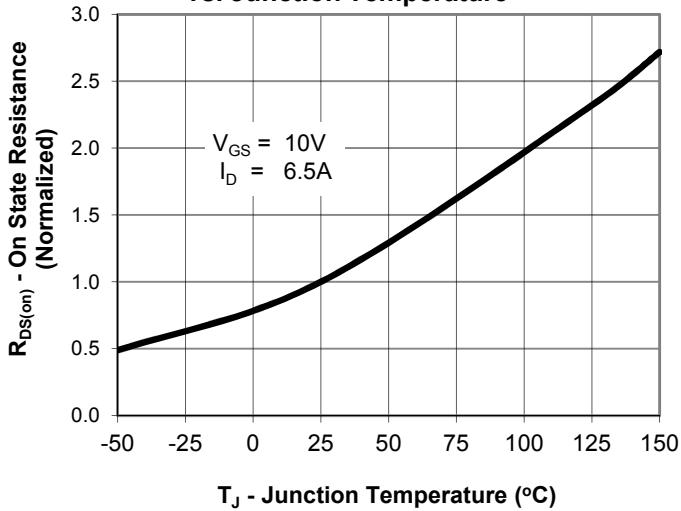
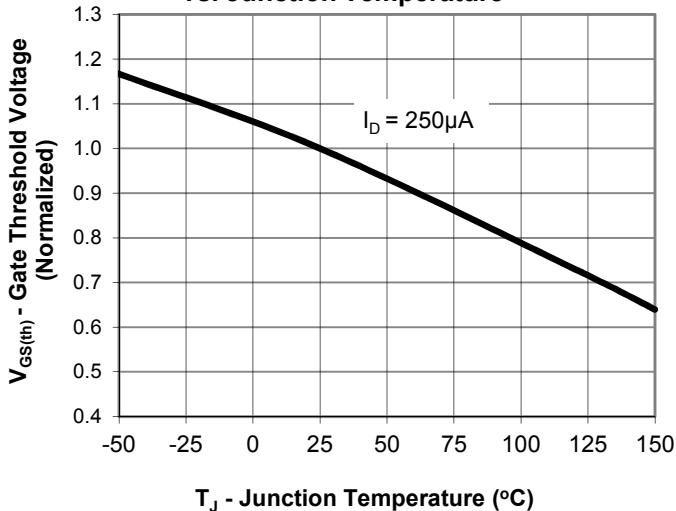
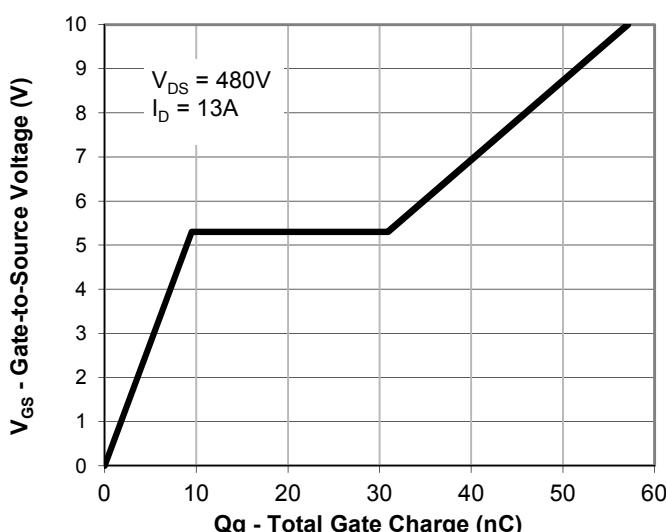
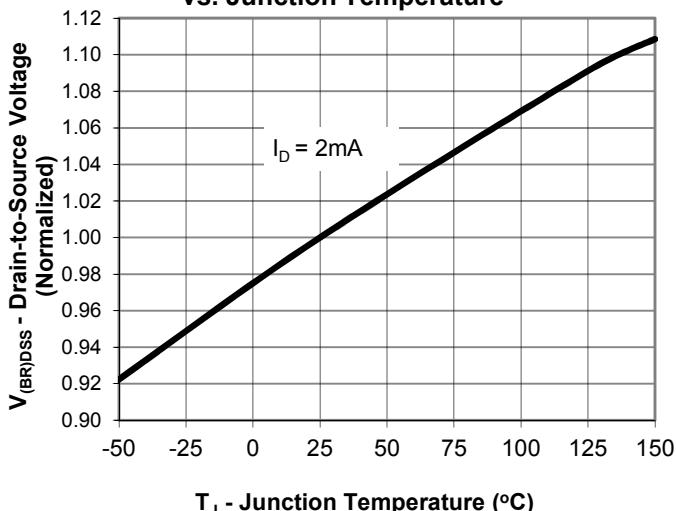
**Gate charge characteristics**

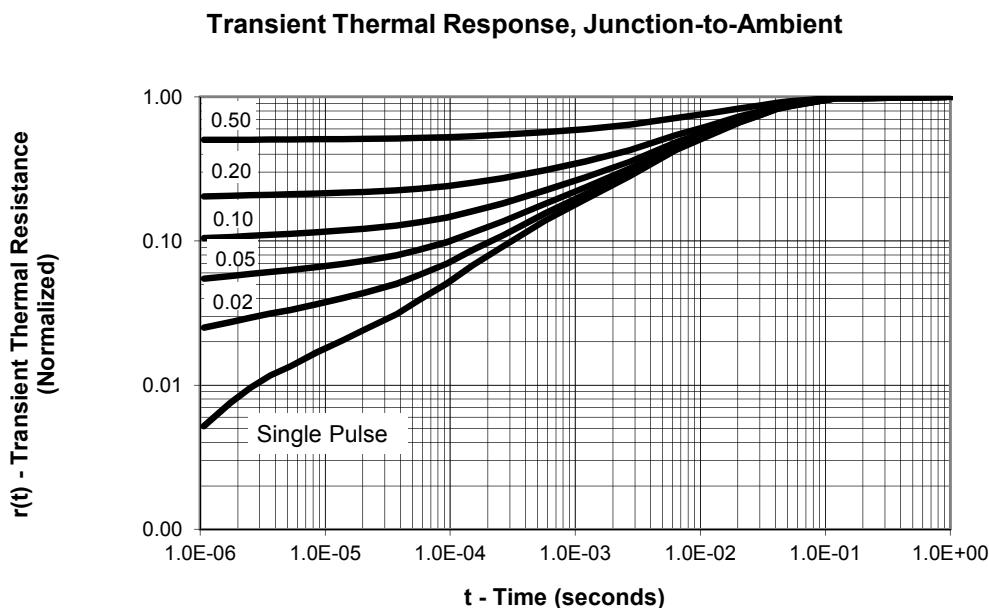
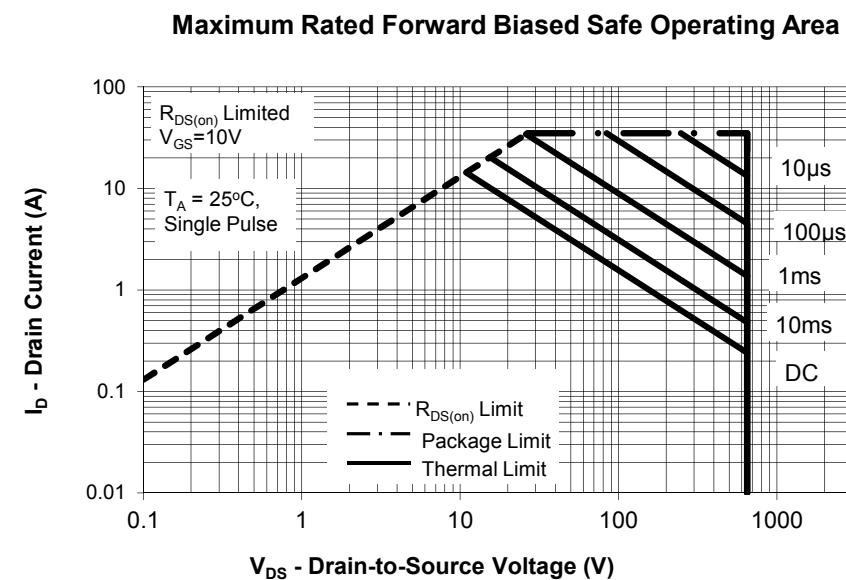
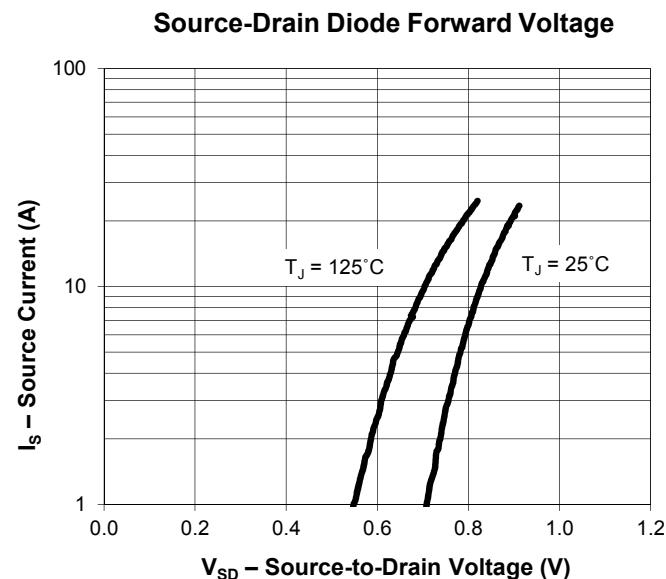
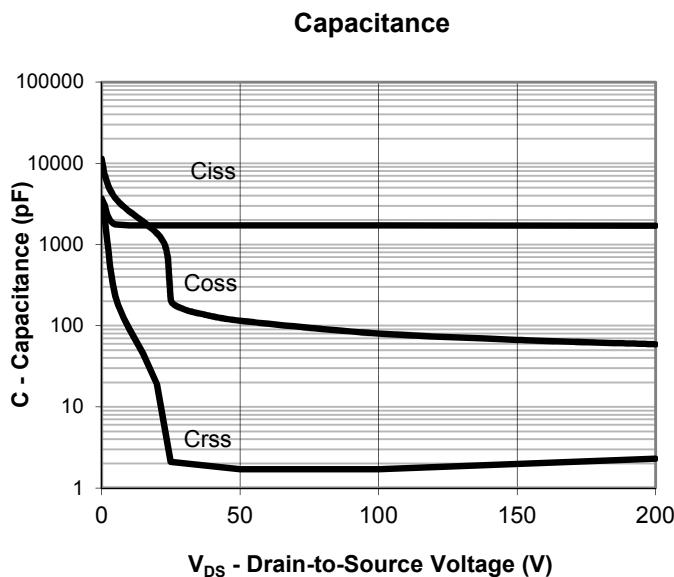
Gate to source charge	$Q_{gs}$	$V_{DS}=480\text{ V}, I_D=15\text{A}, V_{GS}=0\text{ to }10\text{ V}$	-	9.5	-	nC
Gate to drain charge	$Q_{gd}$		-	21.4	-	
Gate charge total	$Q_g$		-	57	-	
Gate plateau voltage	$V_{plateau}$		-	5.3	-	

**Reverse Diode**

Continuous forward current	$I_S$	$V_{GS}=0\text{V}$	-	-	15	A
Diode forward voltage	$V_{SD}$	$V_{GS}=0\text{V}, I_S=I_F$	-	0.9	1.2	V
Reverse recovery time	$t_{rr}$	$V_{RR}=50\text{V}, I_S=I_F, d_{IF}/dt=100\text{ A}/\mu\text{s}$	-	327	-	ns
Reverse recovery charge	$Q_{rr}$		-	5.3	-	$\mu\text{C}$
Peak reverse recovery current	$I_{rm}$		-	29.7	-	A

**Output Characteristics**

**Transfer Characteristics**


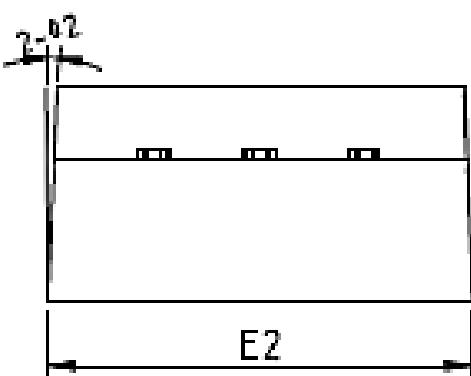
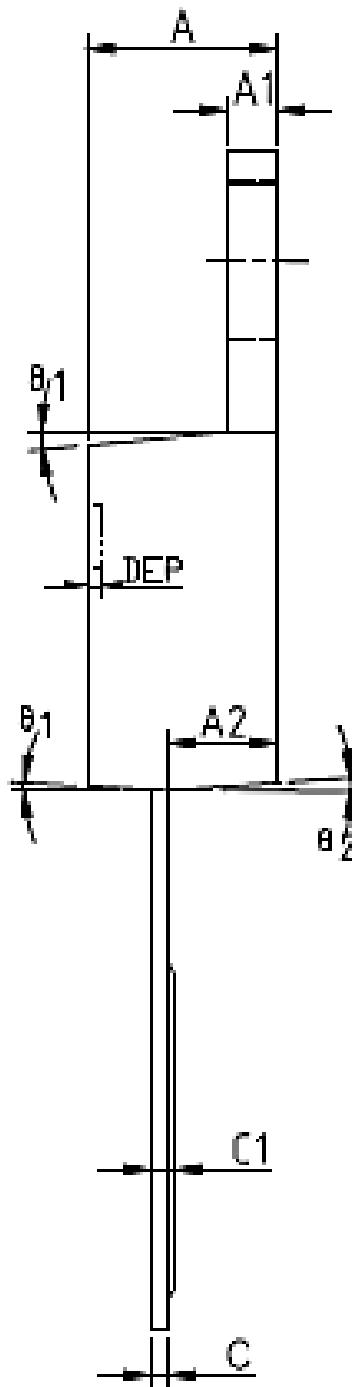
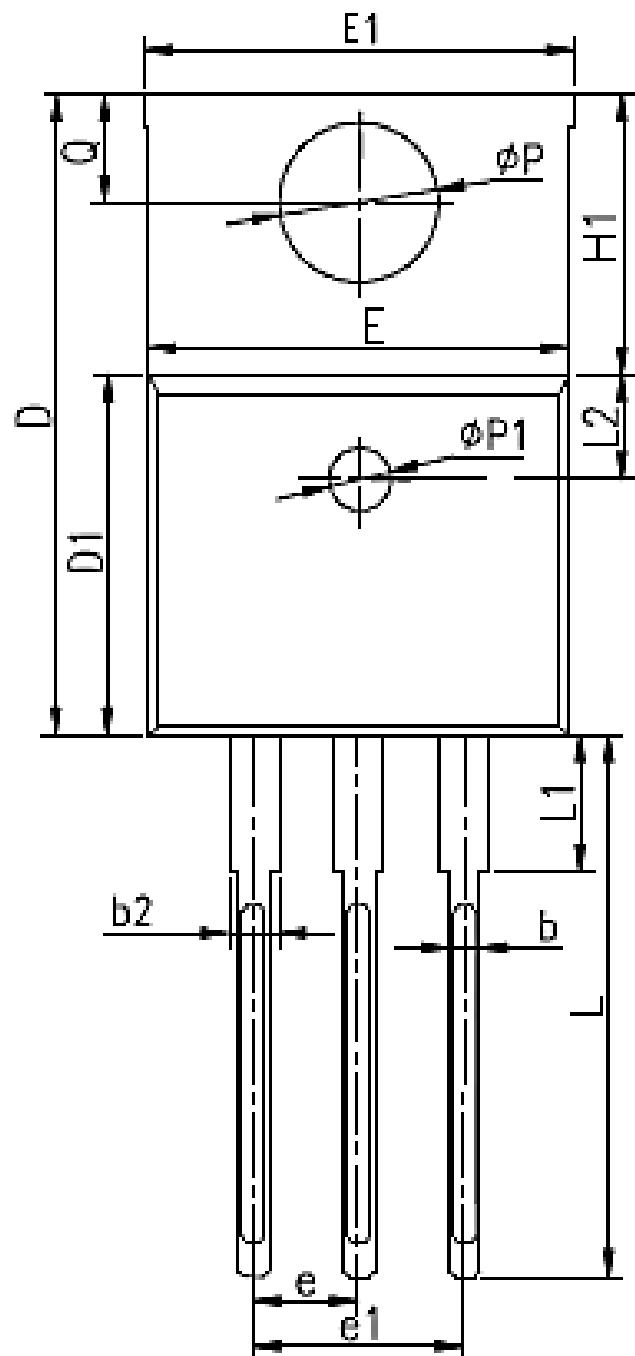
**Drain-Source On-State Resistance vs. Drain Current****Drain-Source On-State Resistance vs. Gate-to-Source Voltage****Drain-Source On State Resistance vs. Junction Temperature****Gate Threshold Voltage vs. Junction Temperature****Gate Charge****Drain-toSource Breakdown Voltage vs. Junction Temperature**





Icemos  
Cooler than cool

ICE15N65



**COMMON DIMENSIONS**

SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
A	3.556	4.191	4.826	0.140	0.165	0.190
A1	0.508	1.397	1.40	0.020	0.055	0.055
A2	2.032	2.476	2.921	0.080	0.097	0.115
b	0.356	0.633	0.91	0.014	0.025	0.036
b2	1.05	1.21	1.37	0.041	0.048	0.054
c	0.31	0.46	0.61	0.012	0.018	0.024
c1	0.33	0.465	0.60	0.013	0.018	0.024
D	14.224	15.367	16.51	0.560	0.605	0.650
D1	8.382	8.816	9.25	0.330	0.347	0.364
E	9.652	10.16	10.668	0.380	0.400	0.420
E1	10.10	10.25	10.35	0.398	0.404	0.407
E2	10.00	10.10	10.20	0.394	0.398	0.402
e	2.54 BSC			0.100 BSC		
e1	5.08 BSC			0.200 BSC		
H1	5.842	6.35	6.858	0.230	0.250	0.270
L	12.70	13.716	14.732	0.500	0.540	0.580
L1	3.56	5.145	6.35	0.140	0.203	0.250
L2	2.50 REF			0.098 REF		
ΦP	3.55	3.72	3.89	0.140	0.146	0.153
Q	2.54	2.997	3.048	0.102	0.108	0.114
θ1	5°	7°	9°	5°	7°	9°
θ2	1°	3°	5°	1°	3°	5°
ΦP1	1.40	1.75	2.10	0.055	0.069	0.083
DEP	0.05	0.10	0.20	0.002	0.004	0.008

## **ICEMOS SUPERJUNCTION PATENT PORTFOLIO**

### **ICEMOS GRANTED PATENTS**

**US7,429,772  
US7,439,178  
US7,446,018  
US7,579,607  
US7,723,172  
US7,795,045  
US7,846,821  
US7,944,018  
US8,012,806  
US8,030,133**

### **3D SEMI PATENTS LICENSED TO ICEMOS**

**US7,041,560B2  
US7,023,069B2  
US7,364,994  
US7,227,197B2  
US7,304,944B2  
US7,052,982B2  
US7,339,252  
US7,410,891  
US7,439,583  
US7,227,197B2  
US6,635,906  
US6,936,867  
US7,015,104  
US9,109,110  
US7,271,067  
US7,354,818  
US7,052,982,  
US7,199,006B2**

**Note: additional patents in China, Korea, Japan, Taiwan, Europe have also been granted to IceMOS and 3D Semi for Superjunction MOSFETs with 70 additional Patent applications in process in the USA and the above listed countries.**

## Marking Information

**YY** = Last two digits of the year

**WW** = Work week calendar on Icemos  
subcon assembly & test house

**\*** = Initial for Icemos subcon  
assembly and test house

**XXXXXX** = Lot ID

**ICE15N65** = ICE is Icemos logo and  
15N65 is a designated device part  
number

